



Title of Change:	Transfer of Final Test location of former Fairchild Small Signal Transistor in SOIC-16 leads package to ON Semiconductor Carmona, Philippines.	
Proposed first ship date:	27 February 2018	
Contact information:	Contact your local ON Semiconductor Sales Office or <zbd6nn@onsemi.com>	
Samples:	Contact your local ON Semiconductor Sales Office	
Additional Reliability Data:	Contact your local ON Semiconductor Sales Office or <ffw3zw@onsemi.com>	
Type of notification:	This is a Final Product/Process Change Notification (FPCN) sent to customers. FPCNs are issued 90 days prior to implementation of the change. ON Semiconductor will consider this change accepted, unless an inquiry is made in writing within 30 days of delivery of this notice. To do so, contact <PCN.Support@onsemi.com>.	
Change Part Identification:	Customer may receive the parts test in ON Semiconductor Carmona, Philippines from month of Feb 2018 once FPCN expire or earlier depending on customers' approvals. Parts tested in ON Semiconductor Philippines can be identified through product packaging and labelling which follow ON Semiconductor standard.	
Change category:	☐ Wafer Fab Change ☐ Assembly Change ☒ Test Change ☐ Other _____	
Change Sub-Category(s):	☒ Manufacturing Site Change/Addition ☐ Material Change ☐ Datasheet/Product Doc change ☐ Manufacturing Process Change ☐ Product specific change ☒ Shipping/Packaging/Marking ☐ Other: _____	
Sites Affected:	ON Semiconductor Sites: ON Carmona, Philippines	External Foundry/Subcon Sites: Amkor, Philippines

Description and Purpose:

This Final Notification announces to customers of its plan to transfer Test operation site of former Fairchild Small Signal Transistor in SOIC-16 package from existing external manufacturing facility to internal manufacturing site ON Semiconductor Carmona, Philippines.

The Philippines internal facility is certified with ISO/TS 16949:2009 and is currently running production for SOC-16 package.

These products will continue being Pb-free, Halide free and RoHS compliant. Qualification tests are designed to show that the reliability of the transferred devices will continue to meet or exceed ON Semiconductor standards.

Material to be changed	Before Change Description	After Change Description
Pizza Box	338x334x43mm (5ku/box)	330x336x49mm (2.5k u/box)
Reel and Pizza Box Labelling		

**Reliability Data Summary:**

No change in form, fit and functions of the devices. Reliability Testing is not required.

Electrical Characteristic Summary:

Data are available upon request.

List of Affected Standard Parts:

Part Number	Qualification Vehicle
MMPQ2907A	MMPQ6700
MMPQ2222A	
MMPQ3904	
MMPQ3906	
MMPQ6700	